

<b>Notice of References Cited</b>	Application/Control No. 10/763,010	Applicant(s)/Patent Under Reexamination BREITSCHWERDT ET AL.	
	Examiner Binh X. Tran	Art Unit 1765	Page 1 of 1

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*	B	US-6,333,269	12-2001	Naito et al.	438/706
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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